

What is claimed is:

1. An actuator assembly comprising:
 - 2 a first attraction only actuator including a first core, a conductor
secured to the first core, and a second core spaced apart a component gap
4 from the first core; and
a control system that directs current to the conductor to attract the
6 second core to the first core, wherein the amount of current directed to the
conductor is calculated without measuring the component gap.
2. The actuator assembly of claim 1 wherein the control system utilized
2 the formula $I = \sqrt{F}$ to calculate the amount of current directed to the conductor,
wherein I is the current and F is the force to be generated by the first actuator.
3. The actuator assembly of claim 1 wherein the control system directs
2 current to the conductor at a plurality of time steps, including t_1 , t_2 , and t_3 , and t_4 .
4. The actuator assembly of claim 1 wherein the control system
2 calculates a calculated gap between the cores at least one of t_1 , t_2 , and t_3 , and
wherein the control system uses the calculated gap to calculate the current that
4 should be directed to the conductor at t_4 .
5. The actuator assembly of claim 1 wherein the control system
2 calculates a calculated gap between the cores at least two of t_1 , t_2 , and t_3 , and
wherein the control system uses the calculated gaps to calculate the current that
4 should be directed to the conductor at t_4 .
6. The actuator assembly of claim 1 wherein the control system adjusts
2 the current to the conductor to create an artificial force that dampens oscillations.
7. The actuator assembly of claim 1 wherein the control system adjusts
2 the current to the conductor to create an artificial force that provides stiffness
compensation.

8. The actuator assembly of claim 1 wherein the first core is somewhat
2 "C" shaped.

9. The actuator assembly of claim 1 wherein the first core is somewhat
2 "E" shaped.

10. The actuator assembly of claim 1 further comprising a second
2 attraction only actuator including a first core, and a conductor secured to the first
core.

11. The stage assembly of claim 1 wherein the first actuator is an
2 electromagnetic actuator.

12. A apparatus including the actuator assembly of claim 1.

13. A polishing apparatus including a polishing pad and the actuator
2 assembly of claim 1 utilized to adjust the position of the pad.

14. A method for making a device that includes the steps of providing a
2 substrate and polishing the substrate with the apparatus according to claim 13.

15. A method for making a wafer that includes the steps of providing a
2 substrate and polishing the substrate with the apparatus according to claim 13.

16. A method for positioning a stage, the method comprising the steps
2 of:

4 coupling a first attraction only actuator to the stage, the first actuator
including a first core, a conductor secured to the first core, and a second
core spaced apart a component gap from the first core; and

6 directing current with a control system to the conductor to attract the
second core to the first core, wherein the amount of current directed to the
8 conductor is calculated without measuring the component gap.

17. The method of claim 16 wherein the control system uses the formula
2 $I = \sqrt{F}$ to calculate the amount of current directed to the conductor, wherein I is the
current and F is the force to be generated by the actuator combination.

18. The method of claim 16 wherein the control system directs current to
2 the conductor at a plurality of time steps, including t_1 , t_2 , and t_3 , and t_4 .

19. The method of claim 16 wherein the control system calculates a
2 calculated gap between the cores at least one of t_1 , t_2 , and t_3 , and wherein the
control system uses the calculated gap to calculate the current that should be
4 directed to the conductor at t_4 .

20. The method of claim 16 wherein the control system calculates a
2 calculated gap between the cores at least two of t_1 , t_2 , and t_3 , and wherein the
control system uses the calculated gaps to calculate the current that should be
4 directed to the conductor at t_4 .

21. The method of claim 16 wherein the control system adjusts the
2 current to the conductor to create an artificial force that dampens oscillations.

22. The method of claim 16 wherein the control system adjusts the
2 current to the conductor to create an artificial force that provides stiffness
compensation.

23. The method of claim 16 wherein the first core is somewhat "C"
2 shaped.

24. The method of claim 16 wherein the first core is somewhat "E"
2 shaped.

25. A method for making an apparatus for polishing a wafer, the method
2 comprising the steps of:
providing a pad;
4 securing the pad to a stage; and
moving the stage by the method of claim 16.

26. A method for making an object including at least a polishing process,
2 wherein the polishing process utilizes the apparatus made by the method of claim
25.

27. A method of making a wafer including the steps of providing a
2 substrate and utilizing the apparatus made by the method of claim 23 to polish the
substrate.